

Advanced Adaptive Test – White paper now Available

OptimalTest is pleased to announce a new white paper on Advanced Adaptive Test is now available.

For Adaptive Test to play a meaningful role as part of an integrated test strategy beyond just Test Time Reduction (TTR), an approach that accommodates and enables the complex, distributed and multi-enterprise semiconductor value chain has been required. Such an approach demands innovative software, robust IT infrastructure and a far more advanced approach to adaptive test. With these capabilities and requirements in mind, OptimalTest has introduced the second generation of Adaptive Test – Advanced Adaptive Test. Advanced Adaptive Test can help you achieve significant improvements in not only TTR but also yield, reliability, quality and overall operational efficiency, scaled from early detection up to global test operations, depending on your needs.

To request a copy of the white paper, please send an e-mail to AAT@optimaltest.com with the words “Advanced Adaptive Testing” in the subject.

This way, we will also include you in our distribution list for future news and bi-monthly newsletters.